

October 2009
UniFETTM

FDP8N50NZ / FDPF8N50NZT N-Channel MOSFET

500V, **8A**, **0.85**Ω

Features

- $R_{DS(on)} = 0.77\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 4A$
- Low Gate Charge (Typ. 14nC)
- Low C_{rss} (Typ. 5pF)
- · Fast Switching
- 100% Avalanche Tested
- · Improve dv/dt Capability
- · ESD Improved Capability
- RoHS Compliant



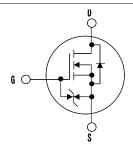
Description

This N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.







MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		FDP8N50NZ	FDPF8N50NZT	Units
V_{DSS}	Drain to Source Voltage	rain to Source Voltage			500	
V_{GSS}	Gate to Source Voltage	Gate to Source Voltage		±25		V
	Drain Current	-Continuous (T _C = 25°C)		8	8*	۸
ID	Drain Current	-Continuous (T _C = 100°C)		4.8	4.8*	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	30	30*	Α
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)) 122		mJ
I _{AR}	Avalanche Current		(Note 1)	8		Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	13.9		mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10		V/ns
Б	Dower Dissipation	$(T_C = 25^{\circ}C)$		139	50	W
P_{D}	Power Dissipation	- Derate above 25°C		1.1	0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 1	to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			;	300	°C

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP8N50NZ	FDPF8N50NZT	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.96	3.1	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	-	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP8N50NZ	FDP8N50NZ	TO-220	-	-	50
FDPF8N50NZT	FDPF8N50NZT	TO-220F	-	=	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A$, $V_{GS} = 0V$, $T_C = 25^{\circ}C$	500	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.5	-	V/°C
	Zoro Coto Voltago Proin Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	1	
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 400V, T_C = 125^{\circ}C$	-	-	10	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 25V, V_{DS} = 0V$	-	-	±10	μΑ

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V$, $I_D = 4A$	•	0.77	0.85	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 4A$ (Note 4)	•	6.3		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	565	735	pF
Coss	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ 	-	80	105	pF
C _{rss}	Reverse Transfer Capacitance	1 - 111112	-	5	10	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	14	18	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 8A$	-	4	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5	-	6	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	17	45	ns	l
t _r	Turn-On Rise Time	$V_{DD} = 250V, I_D = 8A$	-	34	80	ns]
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$, $V_{GS} = 10V$	-	43	95	ns	1
t _f	Turn-Off Fall Time	(Note 4, 5)	-	27	60	ns]

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	8	Α	
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	30	Α	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 8A$		-	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 8A$		-	300	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	1.9	-	μС

- Notes:

 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 3.8mH, I_{AS} = 8A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}C$
- 3. I $_{SD} \le 8 \text{A}, \text{ di/dt} \le 200 \text{A/}\mu\text{s}, \text{ V}_{DD} \le \text{BV}_{DSS}, \text{ Starting T}_J = 25^{\circ}\text{C}$
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \, \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

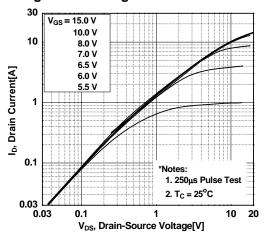


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

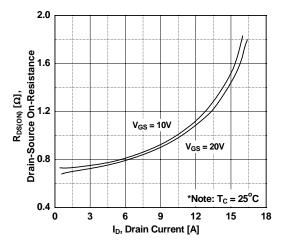


Figure 5. Capacitance Characteristics

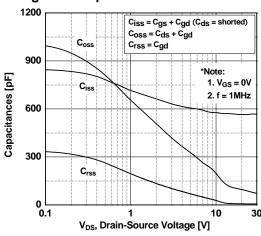


Figure 2. Transfer Characteristics

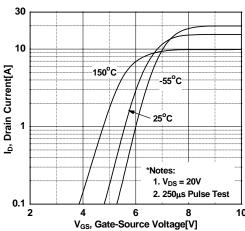


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

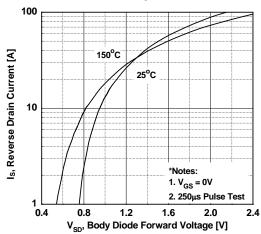
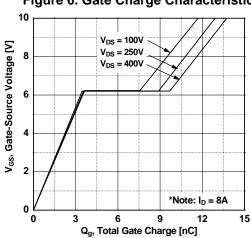


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

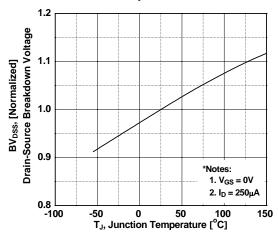


Figure 9. Maximum Safe Operating Area - FDP8N50NZ

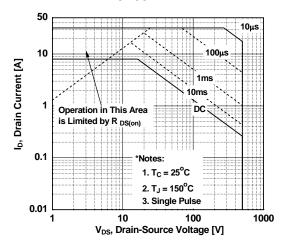


Figure 11. Maximum Drain Current vs. Case Temperature

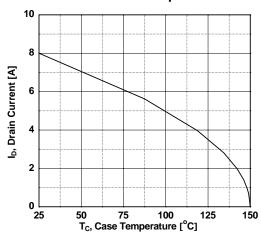


Figure 8. On-Resistance Variation vs. Temperature

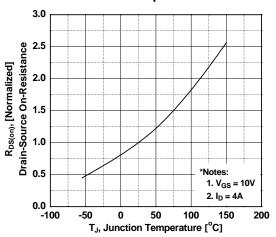
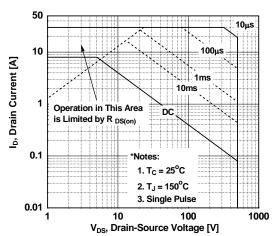


Figure 10. Maximum Safe Operating Area - FDPF8N50NZT



Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve - FDP8N50NZ

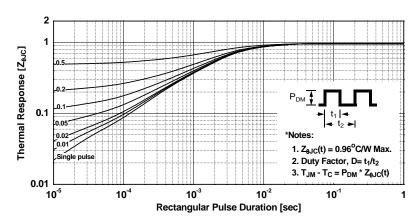
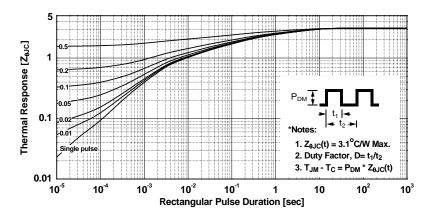
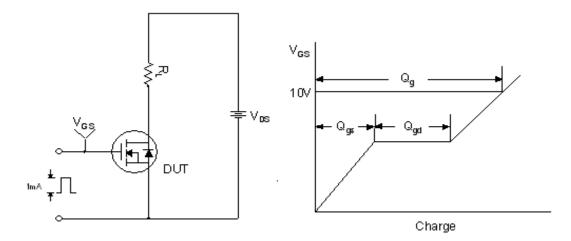


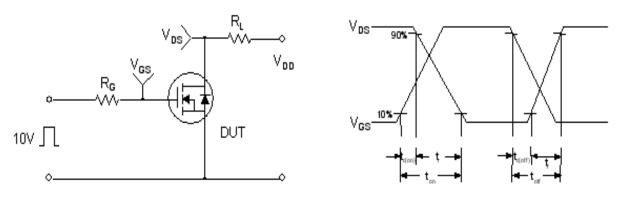
Figure 13. Transient Thermal Response Curve - FDPF8N50NZT



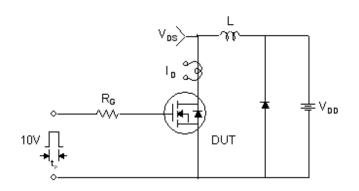
Gate Charge Test Circuit & Waveform

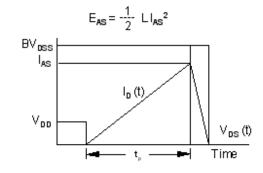


Resistive Switching Test Circuit & Waveforms

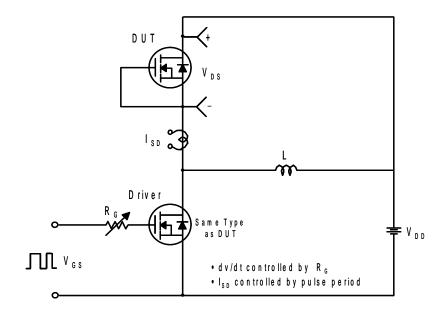


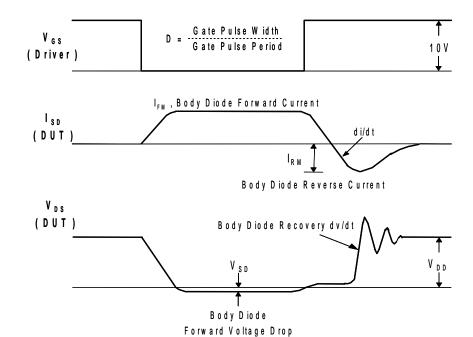
Unclamped Inductive Switching Test Circuit & Waveforms





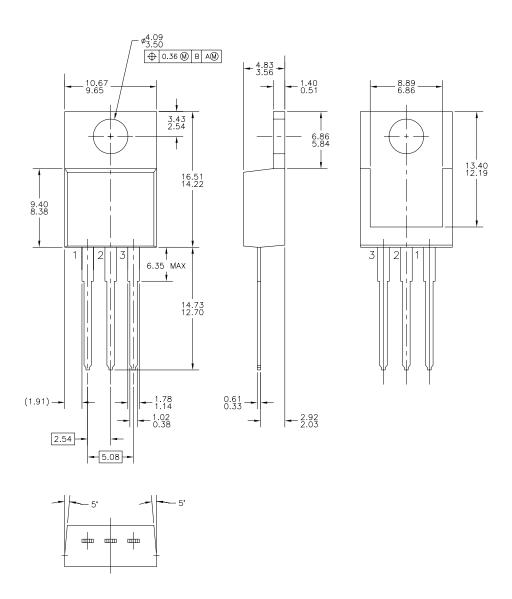
Peak Diode Recovery dv/dt Test Circuit & Waveforms





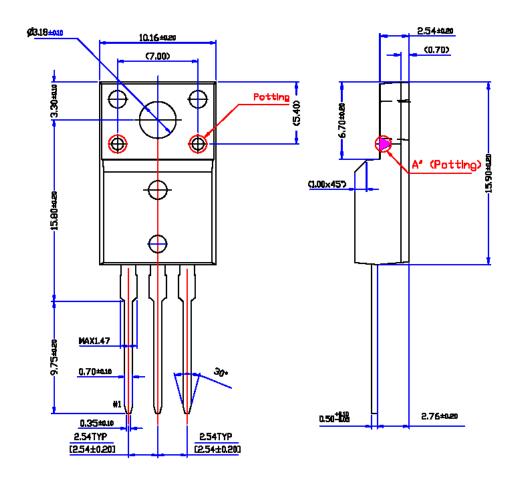
Mechanical Dimensions

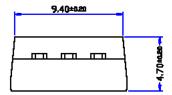
TO-220



Package Dimensions

TO-220F Potted





* Front/Back Side Isolation Voltage: 4000V

Dimensions in Millimeters





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